

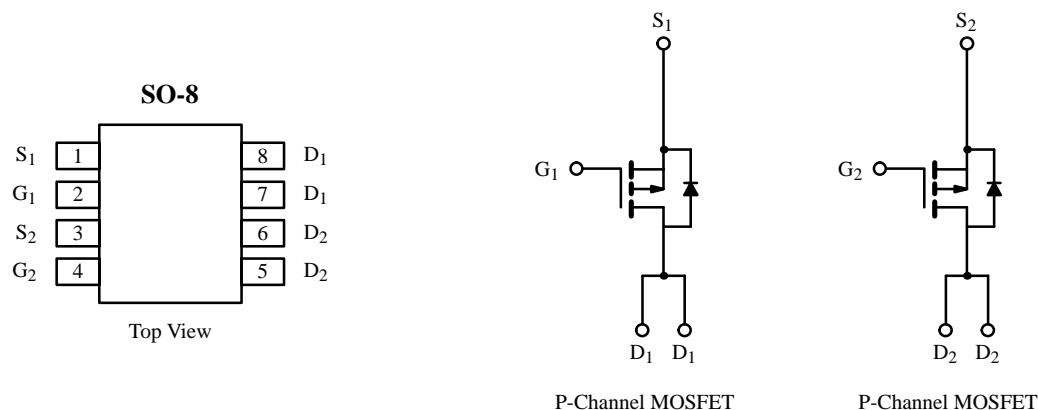
## Dual P-Channel Enhancement-Mode MOSFET

### Product Summary

V <sub>DS</sub> (V)	r <sub>DS(on)</sub> ( $\Omega$ )	I <sub>D</sub> (A)
-20	0.075 @ V <sub>GS</sub> = -4.5 V	± 3.4
	0.105 @ V <sub>GS</sub> = -3.0 V	± 2.9
	0.115 @ V <sub>GS</sub> = -2.7 V	± 2.6

Recommended upgrade: Si9934DY

Lower profile/smaller size see: Si6943DQ



### Absolute Maximum Ratings (T<sub>A</sub> = 25°C Unless Otherwise Noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-20	V
Gate-Source Voltage	V <sub>GS</sub>	± 12	
Continuous Drain Current (T <sub>J</sub> = 150°C) <sup>a</sup>	I <sub>D</sub>	± 3.4	A
		± 2.7	
Pulsed Drain Current	I <sub>DM</sub>	± 16	
Continuous Source Current (Diode Conduction) <sup>a</sup>	I <sub>S</sub>	-2.0	
Maximum Power Dissipation <sup>a</sup>	P <sub>D</sub>	2.0	W
		1.3	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

### Thermal Resistance Ratings

Parameter	Symbol	Limit	Unit
Maximum Junction-to-Ambient <sup>a</sup>	R <sub>thJA</sub>	62.5	°C/W

Notes

a. Surface Mounted on FR4 Board, t ≤ 10 sec.

Updates to this data sheet may be obtained via facsimile by calling Siliconix FaxBack, 1-408-970-5600. Please request FaxBack document #70651. A SPICE Model data sheet is available for this product (FaxBack document #70529).

# Si9933ADY

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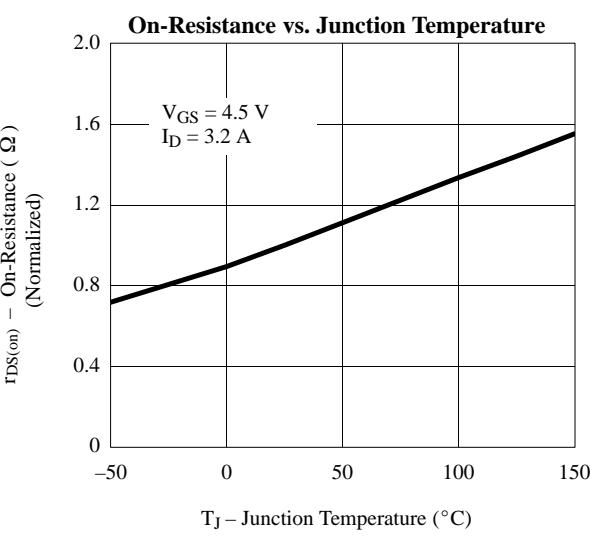
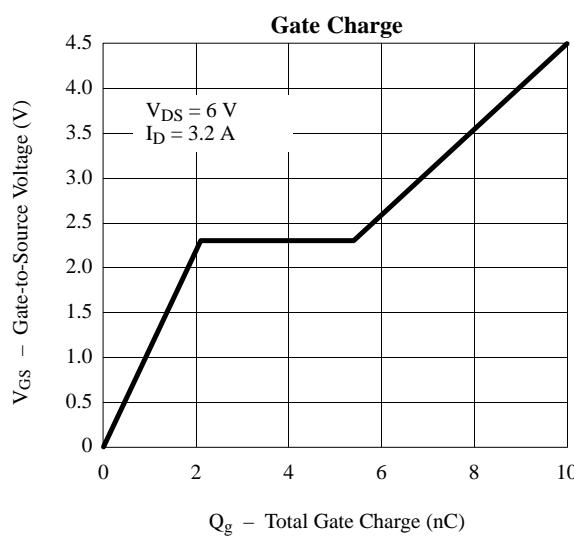
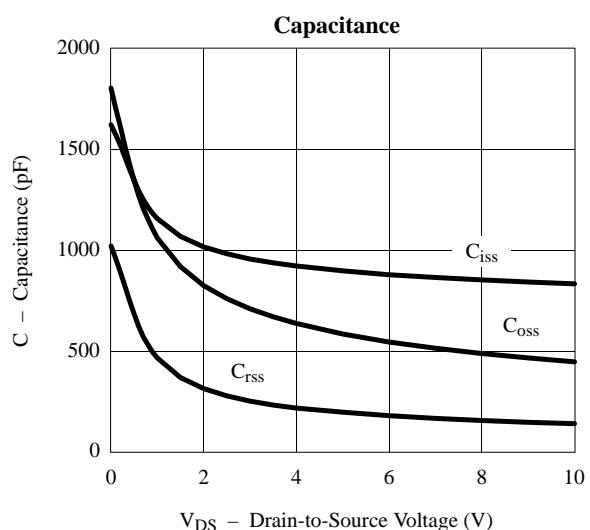
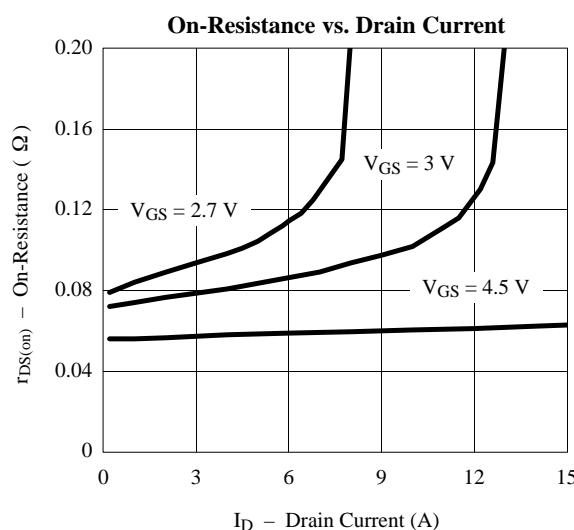
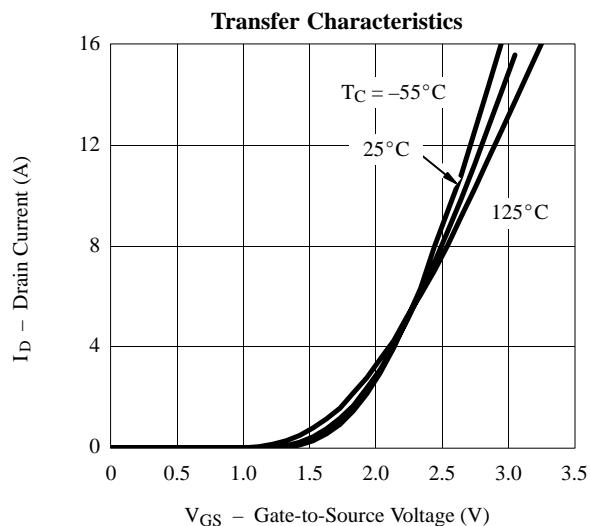
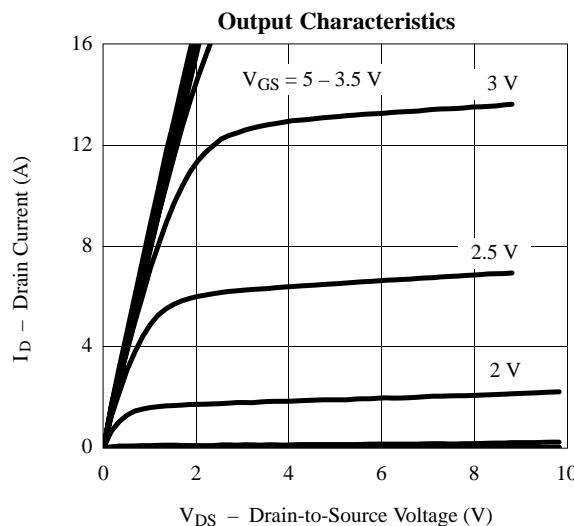
## Specifications ( $T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

Parameter	Symbol	Test Condition	Min	Typ <sup>a</sup>	Max	Unit
<b>Static</b>						
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	-0.8			V
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$		-1		$\mu\text{A}$
		$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^\circ\text{C}$		-3		
On-State Drain Current <sup>b</sup>	$I_{D(\text{on})}$	$V_{DS} \leq -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-16			A
		$V_{DS} \leq -5 \text{ V}, V_{GS} = -2.7 \text{ V}$	-3			
Drain-Source On-State Resistance <sup>b</sup>	$r_{DS(\text{on})}$	$V_{GS} = -4.5 \text{ V}, I_D = -3.2 \text{ A}$		0.06	0.075	$\Omega$
		$V_{GS} = -3.0 \text{ V}, I_D = -2.0 \text{ A}$		0.078	0.105	
		$V_{GS} = -2.7 \text{ V}, I_D = -1 \text{ A}$		0.085	0.115	
Forward Transconductance <sup>b</sup>	$g_{fs}$	$V_{DS} = -9 \text{ V}, I_D = -3.4 \text{ A}$		8		S
Diode Forward Voltage <sup>b</sup>	$V_{SD}$	$I_S = -2.0 \text{ A}, V_{GS} = 0 \text{ V}$		-0.7	-1.2	V
<b>Dynamic<sup>a</sup></b>						
Total Gate Charge	$Q_g$	$V_{DS} = -6 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -3.2 \text{ A}$		10	20	nC
Gate-Source Charge	$Q_{gs}$			2.1		
Gate-Drain Charge	$Q_{gd}$			3.3		
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -6 \text{ V}, R_L = 6 \Omega$ $I_D \cong -1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_G = 6 \Omega$		16	40	ns
Rise Time	$t_r$			46	80	
Turn-Off Delay Time	$t_{d(\text{off})}$			40	70	
Fall Time	$t_f$			25	40	
Source-Drain Reverse Recovery Time	$t_{rr}$	$I_F = -2.0 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$		60	100	

Notes

- a. For design aid only; not subject to production testing.
- b. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .

## Typical Characteristics (25°C Unless Otherwise Noted)



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